

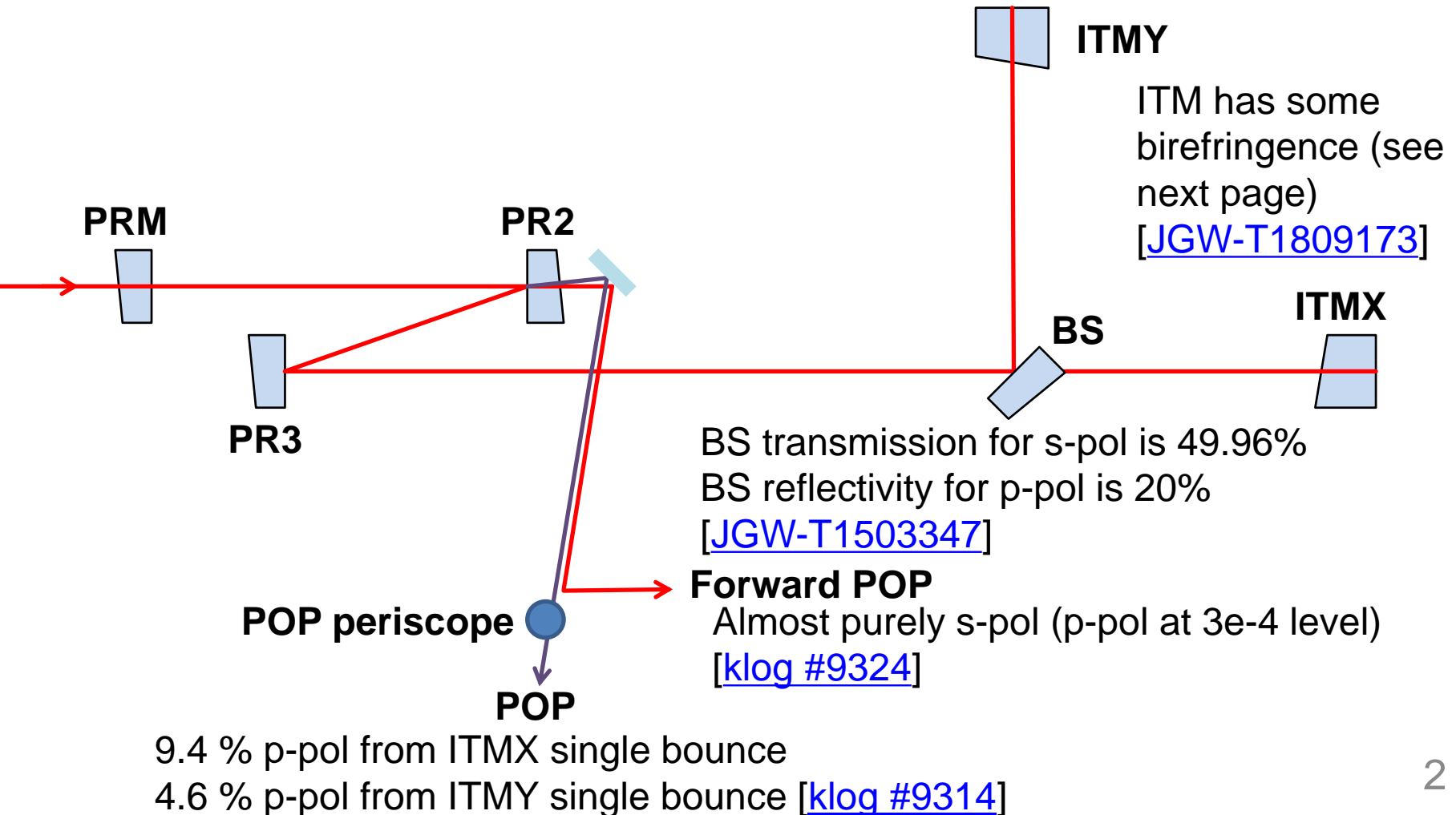
Polarization issue in PRC

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The Situation

- ITM reflection has some p-pol, while forward beam is almost purely s-pol



ITM Birefringence

- Vendor measured transmission wavefront error (TWE) with circular polarization, but TWE measured with s-pol was different

[JGW-T1809173](#)

	specification	vendor report	measured
ITMX	< 6nm	3.47	25.9nm
ITMY	< 6nm	4.07	30.1nm

Table 6. figure error of TWE at 140mm aperture

- This suggests that ITM has some birefringence
- Optical path length difference between two polarizations Δl_b gives polarization rotation of

$$\phi = \pi \Delta l_b / \lambda$$

ITM Birefringence

- If we treat RMS linearly, Δl_b can be written as
$$\Delta l_b = l_p - l_s = 2l_u - 2l_s$$
where $l_{u/s/p}$ are the optical path length measured with circular polarization and s/p polarization
- The power loss due to s-pol turning into p-pol is therefore written as
$$\rho = 1 - \cos^2 2\phi$$
(2 for double pass inside ITM substrate)
- The power loss will be 6.8% for X and 9.2% for Y
- This corresponds to the power ratio at POP ($p/(s+p)$) of 9.3 % for X and 5.7 % for Y (note that BS reflectivity is different between polarizations)
- This seems to (amazingly) agree with the measurement (9.4% for X and 4.8% for Y)

Implications

- We need both uniform l_s and small Δl_b but this cannot be achieved by surface corrections
- Using ordinary and extraordinary refractive indices,

Δl_b can be written as

$$\Delta l_b = dn_o(n_o^2 - n_e^2)\theta^2/n_e^2$$

For sapphire @ 1064 nm

$$n_e = 1.747$$

where θ is angle between c-axis and beam axis, [JGW-T0400030](#)

$$n_o = 1.754$$

and d is ITM thickness (15cm)

- If we require loss to be smaller than a threshold,

$$\Delta l_b < \sqrt{\lambda^2 \rho_{th} / (2\pi)^2}$$

$$\theta < \sqrt{\frac{n_e^2 \sqrt{\lambda^2 \rho_{th} / (2\pi)^2}}{dn_o(n_o^2 - n_e^2)}}$$

For 100ppm loss, these will be 5 nm and 0.09 deg

